

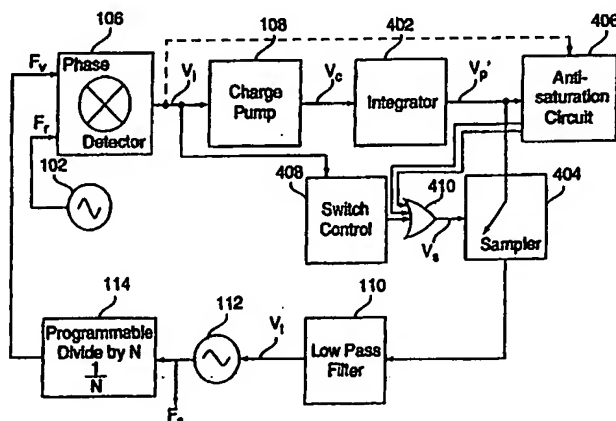
PCT

WORLD INTELLECTUAL PROPERTY ORGANIZATION
International Bureau

INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(51) International Patent Classification 6 : H03L 7/093	A1	(11) International Publication Number: WO 98/23035 (43) International Publication Date: 28 May 1998 (28.05.98)
(21) International Application Number: PCT/US97/20612 (22) International Filing Date: 12 November 1997 (12.11.97) (30) Priority Data: 08/751,571 18 November 1996 (18.11.96) US (71) Applicant: PEREGRINE SEMICONDUCTOR CORPORATION [US/US]; 6175 Nancy Ridge Drive, San Diego, CA 92121 (US). (72) Inventor: DENNY, Paul, A.; 10185 Parkwood Drive #9, Cupertino, CA 95014 (US). (74) Agent: CARY, Charles, C.; Wilson, Sonsini, Goodrich & Rosati, 650 Page Mill Road, Palo Alto, CA 94304-1050 (US).		(81) Designated State: JP. Published <i>With international search report. Before the expiration of the time limit for amending the claims and to be republished in the event of the receipt of amendments.</i>

(54) Title: AN APPARATUS AND METHOD FOR REDUCING SPURIOUS SIDEBANDS IN PHASE LOCKED LOOPS



(57) Abstract

An apparatus and method for reducing spurious sidebands in the tuning signal of phase locked loop frequency synthesizers and phase locked loops is disclosed. A frequency synthesizer comprises an oscillator, a divider, a difference circuit and a sampling circuit. The oscillator produces a variable frequency oscillator signal in response to an applied tuning signal. The divider circuit has a division factor and communicates with the oscillator to receive and divide the variable frequency oscillator signal by the division factor to produce a reduced frequency signal. The difference circuit communicates with the divider circuit to receive the reduced frequency signal and produce a difference signal. The difference signal corresponds to the phase difference between the reference signal and the reduced frequency signal. The sample circuit intermittently samples the difference signal in response to timing signal to produce a tuning signal which approaches a DC characteristic. The tuning signal serves to adjust the oscillator frequency in a direction to diminish phase differences in the reference signal and the reduced frequency signal. In another aspect of the invention, a PLL is disclosed with the sampling circuitry for intermittently sampling the difference signal in response to a timing signal.

FOR THE PURPOSES OF INFORMATION ONLY

Codes used to identify States party to the PCT on the front pages of pamphlets publishing international applications under the PCT.

AL	Albania	ES	Spain	LS	Lesotho	SI	Slovenia
AM	Armenia	FI	Finland	LT	Lithuania	SK	Slovakia
AT	Austria	FR	France	LU	Luxembourg	SN	Senegal
AU	Australia	GA	Gabon	LV	Latvia	SZ	Swaziland
AZ	Azerbaijan	GB	United Kingdom	MC	Monaco	TD	Chad
BA	Bosnia and Herzegovina	GE	Georgia	MD	Republic of Moldova	TG	Togo
BB	Barbados	GH	Ghana	MG	Madagascar	TJ	Tajikistan
BE	Belgium	GN	Guinea	MK	The former Yugoslav Republic of Macedonia	TM	Turkmenistan
BF	Burkina Faso	GR	Greece	ML	Mali	TR	Turkey
BG	Bulgaria	HU	Hungary	MN	Mongolia	TT	Trinidad and Tobago
BJ	Benin	IE	Ireland	MR	Mauritania	UA	Ukraine
BR	Brazil	IL	Israel	MW	Malawi	UG	Uganda
BY	Belarus	IS	Iceland	MX	Mexico	US	United States of America
CA	Canada	IT	Italy	NE	Niger	UZ	Uzbekistan
CF	Central African Republic	JP	Japan	NL	Netherlands	VN	Viet Nam
CG	Congo	KE	Kenya	NO	Norway	YU	Yugoslavia
CH	Switzerland	KG	Kyrgyzstan	NZ	New Zealand	ZW	Zimbabwe
CI	Côte d'Ivoire	KP	Democratic People's Republic of Korea	PL	Poland		
CM	Cameroon	KR	Republic of Korea	PT	Portugal		
CN	China	KZ	Kazakhstan	RO	Romania		
CU	Cuba	LC	Saint Lucia	RU	Russian Federation		
CZ	Czech Republic	LI	Liechtenstein	SD	Sudan		
DE	Germany	LK	Sri Lanka	SE	Sweden		
DK	Denmark	LR	Liberia	SG	Singapore		
EE	Estonia						

AN APPARATUS AND METHOD FOR REDUCING SPURIOUS SIDEBANDS IN PHASE LOCKED LOOPS

BACKGROUND OF THE INVENTION

Field of the Invention

The field of the invention relates generally to phase locked frequency synthesizers, and more particularly, to an apparatus and method to reduce the spurious sidebands in phase locked loops including integer and fractional phase locked loop synthesizers.

5

Description of the Related Art

Many modulation, detection, and frequency-synthesis methods, long recognized but difficult to implement, have become practical with the introduction of IC versions of the phase-locked loop (PLL). A simplified account of a PLL is a
10 negative feedback system that maintains a constant phase and zero frequency difference between a reference frequency (F_r) and a variable frequency. There are many circuits commonly used as phase detectors in typical industry practice. Description of available types and their operation can be found in *Phase-Locked Loops Theory, Design and Applications*, authored by Roland E. Best, 1993, pps. 93-
15 104 and in *Frequency Synthesis by Phase Lock*, authored by William Egan, 1990, pps. 98-123 (ISBN 0-89464-456-4), which are incorporated herein by reference. One type of phase detector is the linear mixer phase detector, in which two sinusoidal inputs are multiplied to output a sine wave whose frequency is the difference between the input frequencies. Another type is the sample and hold phase detector where a
20 linear representation of the phase of one input signal is instantaneously sampled once per cycle of a second input. The output is maintained by a hold circuit until the next phase sample occurs. A further type is the exclusive-OR phase detector which

-2-

accepts two square wave digital inputs and provides an exclusive-OR output, proportionate to the phase difference in the inputs. The most widely used phase detector in commercial IC phase-locked loops and frequency synthesizers is the phase-frequency detector. This detector has the highly desirable characteristic of providing both a phase difference signal and a frequency difference signal, which assures frequency acquisition.

Many electronic systems require an accurate frequency reference that can be programmed to one of a number of required values. For example, a FM radio must tune to 87.9 MHz, 88.1 MHz, 88.3 MHz...107.7 MHz, 107.9 MHz. In this case, the radio's receiver must embody a frequency reference that can tune over a 20 MHz range with a step size of 200 KHz. This tuning function is often implemented by a phase locked loop equipped for frequency synthesis. If the PLL is configured for frequency synthesis, it will also include a programmable divider.

Fig. 1 is a simplified block diagram illustrating an example of a typical phase locked loop (PLL) implemented as a frequency synthesizer. Fig. 1 serves as only one example of a PLL and is not limited to the following described elements. The PLL synthesizer comprises a reference signal generator 102, a phase detector 106, a charge pump 108, a low pass filter 110, a voltage controlled oscillator (VCO) 112 and a programmable divider 114. The output of the phase detector is connected to the input of the charge pump. The output of the charge pump (V_p) provides input to the low pass filter 110. The output of the low pass filter is the tuning control voltage (V_o). V_i is the input for VCO 112. The output of the VCO is the synthesized frequency (F_s). F_s is the input for the programmable divider. The programmable divider reduces the frequency F_s by a predetermined amount and outputs this lower frequency signal (F_v). F_v is an input of the phase detector. The other input of the phase detector is the output F_r of reference signal generator. In many frequency synthesizers the reference signal is itself derived from a signal reduced in frequency

-3-

by a separate divider. A PLL implemented in this manner is known as a frequency synthesizer in that it can produce any number of output frequencies F_s from a single F_r depending on the value of the variable N.

Fig. 2 of the prior art illustrates a more detailed view of some of the elements shown in PLL 100 of Fig 1. The phase detector 106 accepts as inputs F_r and F_v and provides as outputs an up-line 202 and down-line 204 to current sources 206A and 206B, respectively of charge pump 108. The current sources are connected to supply and ground and provide an input to VCO 112 through a connecting node V_p . If F_r falls before F_v , the up-line 204 is asserted. If F_v falls before F_r , the down-line 202 is asserted. The low pass filter 110 is implemented as a passive lag lead filter and comprises capacitors 208A-B, and a resistor 210 which are all connected to ground. Typically, the low pass filter 110 is used to integrate current before it reaches the VCO 112.

The critical node in any phase locked loop is the output node V_p as shown in Figs. 1-2. As mentioned above, node V_p provides input to the VCO. Ideally, this voltage is purely DC with only error correction information present. However, in practice this goal is not easily achieved. Practical issues can introduce AC voltages, and hence unwanted FM sidebands in the synthesizer. These sidebands interfere with the ability of the PLL to keep F_r and F_v in phase lock. There are three primary causes for the introduction of spurious sidebands into the output of node V_p : charge pump leakage, current source mismatch, and sidebands resulting from the circuitry utilized in PLLs of the frequency synthesizer type.

Charge pump leakage results from the deviation from ideal performance of the components utilized in the charge pump. In charge pump 108 of Fig. 2, at least one of the current sources 206A or 206B has at least one half of the charge pump supply voltage impressed across it. As the current sources are typically constructed with nonideal transistors, this voltage causes leakage current through the transistors

-4-

when the current sources should ideally be in the OFF state. This leakage current causes the capacitors 208A-B in the low pass filter 110 to charge (or discharge) during the OFF state of the charge pump. This charge is replaced periodically at each phase detector comparison cycle. The charge pump leakage causes a sawtooth waveform on node V_p . This introduces unwanted sidebands in the spectrum of F_r , thus resulting in incomplete phase lock. Ideally, a pure DC waveform is desired for node V_p .

The second source of unwanted sidebands in the output of V_p is mismatched current sources. When the frequency and phase of F_v and F_r are equal, the charge pump 108 will output both up and down pulses of current, which are ideally equal and opposite, in order for the net charge injected into the low pass filter to be zero. However, because the Up and Down current sources 206A and 206B are usually constructed from complementary devices with nonsymmetrical characteristics, it is difficult to match the output current pulses rise/fall times and amplitudes. This mismatch results in transient voltage disturbances on output node V_p at the comparison frequency rate, and hence unwanted sidebands in the synthesizer output spectrum and therefore incomplete phase lock.

The final source of undesirable sidebands in the output of node V_p is the fractional division process associated with fractional-N frequency synthesizers. There are two types of division circuitry associated with frequency synthesis. These are called integer-N and fractional-N. In an integer-N divider, a denominator N is variable in integer steps. It follows that the smallest step change in the output frequency would be equal to F_r , and that tuning would only be possible at integer multiples of that F_r . In order to produce much smaller step changes in the output frequency, circuitry known as fractional-N has been devised. There are a number of ways to divide by fractions in fractional-N phase locked synthesizer technology. However, the methods are typically based on the principle of switching the divide

-5-

ratio of the programmable VCO divider, between different values on successive comparison cycles of the phase detector. For example, a divide ratio of 100.5 could be achieved by alternately switching the programmable VCO denominator between 100 and 101. As the denominator switches output frequency, unwanted sidebands are introduced in the output spectrum of F_o . This can result in less than optimal tracking or signal lock, and is particularly noticeable in systems that require fine frequency resolution and high output frequencies. The sidebands introduced by the fractional division process can not be completely removed by low pass filtering and as a result, the signal phase lock is affected.

---Within the limited context of reducing spurious sidebands due to the fractional division process, several conventional approaches exist. One conventional method for fractional sideband compensation is described in U.S. Patent No. 5,038,120, entitled *Frequency Modulated Phase Locked Loop with Fractional Divider and Jitter Compensation*, issued to Wheatley et al., which is hereby incorporated by reference. This patent employs a digital accumulator to store the fractional phase error and relies on the fact that the numeric value stored in the accumulator at any time is proportional to the instantaneous systematic phase error. This method uses a digital to analog converter to generate a current that is proportional to the accumulator contents (and hence the systematic phase error). This current is then subtracted from the charge pump output of the phase detector to reduce unwanted sidebands.

Another conventional method for fractional sideband compensation is referred to as a digital spurious reduction. There have been a number of proposals concerning digital timing methods to reduce the fractional sidebands in fractional-N synthesizers. One particular method is described in U.S. Patent No. 5,124,670, entitled *Frequency Synthesizers with Fractional Division*, issued to Lawton, which is hereby incorporated by reference. These methods use digital techniques such as, a sigma

-6-

delta modulation to spread the sideband energy and increase its frequency so that the sideband can be more completely removed by the filter.

Yet another conventional method for fractional sideband compensation is referred to as phase interpolation. Phase interpolation methods recognize that the error in many architectures of fractional-N synthesizers takes a known form. These methods attempt to adjust the phase of the VCO in an open loop circuit that attempts to cancel the known phase error introduced in the division process. One form of this method is described in U.S. Patent No. 4,206,425, entitled *Digitized Frequency Synthesizer*, issued to Nossen, which is hereby incorporated by reference.

None of the conventional methods address the elimination of spurious sidebands introduced into node V_p as a result of charge pump leakage or component mismatch. Some of the above mentioned techniques do address the problem of reducing spurious sidebands resulting from fractional-N circuitry, but do so by introducing higher order sidebands.

What is needed is a PLL in which spurious sidebands at the critical node V_p are reduced, and in which the degradation in tracking due to the fractional division process are substantially eliminated.

-7-

SUMMARY OF THE INVENTION

The present invention has been made in view of the above problems and an object thereof, is to provide a PLL, a PLL synthesizer and an operating method therefore, having reduced tracking error resulting from AC modulation on a node V_i .

5 A further object of this invention, is to provide a phase locked loop PLL in which the voltage obtained from the node V_i approaches a DC characteristic.

In one aspect of the invention, a frequency synthesizer comprises an oscillator, a divider, a difference circuit and a sampling circuit. The oscillator produces a variable frequency oscillator signal in response to an applied tuning signal.

10 The divider circuit has a division factor and communicates with the oscillator to receive and divide the variable frequency oscillator signal by the division factor to produce a reduced frequency signal. The difference circuit communicates with the divider circuit to receive the reduced frequency signal and produce a difference signal. The difference signal corresponds to the phase difference between the

15 reference signal and the reduced frequency signal. The sample circuit intermittently samples the difference signal in response to a timing signal to produce a tuning signal which approaches a DC characteristic. The tuning signal serves to adjust the oscillator frequency in a direction to diminish phase differences in the reference signal and the reduced frequency output of the divider.

20 In another aspect of the invention the divider circuit of the frequency synthesizer, rather than communicating with the oscillator, instead receives the reference signal and produces the reduced frequency signal which is communicated to the difference circuit. The oscillator supplies the variable frequency oscillator signal to the difference circuit. The tuning signal serves to adjust the oscillator frequency in

25 a direction to diminish phase differences in the oscillator signal and the reduced frequency signal.

-8-

In another aspect of the invention a PLL is disclosed with the sampling circuitry for intermittently sampling the difference signal in response to a timing signal. The sampling that takes place in both the frequency synthesizers and the PLL reduces spurious sidebands on the tuning signal and thereby produces a variable
5 frequency oscillator signal having more stable characteristics.

In another aspect of the invention a difference circuit is disclosed. The difference circuit comprises, a phase comparator, an integrator, a sample circuit, and a hold circuit. The phase comparator receives a first and second signal to produce an instantaneous phase difference signal, corresponding to the instantaneous
10 phase difference of the first and second signal. The integrator receives and integrates the instantaneous phase difference signal to produce a difference signal. The sample circuit, samples the voltage level of the difference signal in response to an applied timing signal. The hold circuit holds the sampled voltage level of the difference signal and produces a tuning signal. The tuning signal corresponds to the held voltage level
15 of the difference signal.

In still another aspect of the invention, a method for operating a frequency synthesizer is disclosed. An oscillator signal is generated which has a frequency corresponding to an applied tuning signal. The oscillator signal is divided by a division factor which may be integer-N or fractional-N to generate a reduced
20 frequency signal. The reduced frequency signal and a reference signal are used to generate a difference signal proportional to a phase difference between the reference signal and the reduced frequency signal. The difference signal is sampled in response to an applied timing signal to produce a tuning signal. The tuning signal produced by the sampling step has reduced AC modulation and therefore produces a
25 stable oscillator signal.

In another aspect of the invention another method for operating a frequency synthesizer is disclosed. The reference signal is divided by a division factor which

-9-

may be integer-N or fractional-N to generate a reduced frequency signal. The oscillator signal and the reduced frequency signal are used to generate a difference signal proportional to a phase difference between the oscillator signal and the reduced frequency signal. The difference signal is sampled in response to an applied timing signal to produce a tuning signal.

In another aspect of the invention a method for operating a PLL is disclosed which includes sampling the difference signal in response to an applied timing signal to produce a tuning signal. The tuning signal is used to adjust the oscillator signal. The operating methods for both the frequency synthesizers and the PLL reduce spurious sidebands which degrade performance.

In another aspect of the invention a method for operating a difference circuit is disclosed. A first signal and second signal are combined to produce an instantaneous phase difference signal, such that the instantaneous phase difference signal corresponds to an instantaneous phase difference of the first and the second signal. The instantaneous phase difference signal is integrated to produce the difference signal. A voltage level of the difference signal is sampled in response to an applied timing signal. The sampled voltage level is held and output as a tuning signal.

BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1 is a block diagram example of a conventional phase locked loop frequency synthesizer.

Fig. 2 is a detailed block diagram of a portion of the conventional synthesizer of Fig. 1.

Fig. 3 is an illustrative block diagram of an integer-N phase locked frequency synthesizer in accordance with a present preferred embodiment of the invention.

Fig. 4 is a transistor and gate level diagram of a portion of the integer-N phase locked frequency synthesizer of Fig. 3.

-10-

Fig. 5A-D provide illustrative drawings of waveforms for the integer-N synthesizer of Figs. 3-4.

Fig. 6 is a block diagram of a fractional-N phase locked frequency synthesizer.

5 Fig. 7 is a detailed block diagram of a portion of the fractional-N phase locked frequency synthesizer of Fig. 6.

Fig. 8A-D provide illustrative drawings of waveforms for the fractional-N synthesizer of Figs. 6-7.

10 DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

The present invention comprises a novel PLL and associated method of operation. The following description is presented to enable any person skilled in the art to make and use the invention. Descriptions of specific applications are provided only as examples. Various modifications to the preferred embodiment will be readily
15 apparent to those skilled in the art, and the generic principles defined herein may be applied to other embodiments and applications, without departing from the spirit and scope of the invention. Thus, the present invention is not intended to be limited to the embodiments shown, but is to be accorded the widest scope consistent with the principles and features disclosed herein.

20 The present invention provides a PLL, a PLL synthesizer and operating method therefore, having reduced tracking error resulting from spurious sidebands at the output of the phase detector on node V_p' . The " V_p' " notation is used to notate the critical node voltage for the present invention. The voltage V_p' is sampled rather than being continuously provided to the input of the VCO. The benefits of sampling
25 the voltage V_p' are twofold. First, spurious sidebands introduced by leakage and current source mismatch are reduced. Second spurious sidebands introduced by the fractional division process of frequency synthesis are reduced.

-11-

Fig. 3 is an illustrative diagram of an integer-N phase locked frequency synthesizer in accordance with a presently preferred embodiment of the invention. The phase locked loop is referred to as a frequency synthesizer because it can produce any number of output frequencies F_r from a single F_r depending on the value of the integer variable N. The synthesizer comprises a reference frequency F_r generator 102, a difference circuit, a sampling circuit, a voltage controlled oscillator 112 and a programmable divider 114. In a current embodiment, the difference circuit comprises a phase detector 106, a charge pump 108 and an integrator 402. The sampling circuit comprises a sampler 404, an anti-saturation circuit 406, a switch control 408 and OR gate 410 and low pass filter 110.

The phase detector 106 has two inputs and one output. The first input is connected to a source for a variable frequency F_v . The second input is connected to a reference frequency F_r generator 102. The output of the phase detector is connected to the input of charge pump 108 and may additionally be connected to anti-saturation circuit 406. The output of charge pump 108 is connected to the input of integrator 402. The output of integrator 402 is connected to an input of anti-saturation circuit 406 and to sampler 404. The output of anti-saturation circuit 406 is connected to an input of OR gate 410. The other input of OR gate is connected to the output of switch control 408. The output of OR gate 410 is connected to a second input of sampler 404. The output of sampler 404 is connected to the input of low pass filter 110. The output of low pass filter 110 is connected to the input of VCO 112. The output of VCO 112 is connected to the input of programmable divider 114. The output of programmable divider 114 is connected to the first input of phase detector 106.

Fig. 4 is an illustrative transistor level and gate level diagram of the difference and sampling circuit portions of Fig. 3. Charge pump 108 comprises current sources 206A-B. Integrator 402 comprises a single capacitor 504. Sampler 404 comprises

-12-

transmission gate transistors 506A-B and inverter 514. Low pass filter 110 comprises capacitors 208A-B and resistor 210. Anti-saturation circuit 406 comprises resistors 516, 518, 524, 526 and comparators 522, 528. Switch control 408 comprises NOR gate 508, delay device 510 and monostable element 512.

5 The output from the phase detector is shown as comprising an up-line 202 and a down-line 204. The up-line 202 is connected both to current source 206A and to an input of NOR gate 508. The down-line 204 is connected both to current source 206B and to the remaining input of NOR gate 508. Current source 206A and 206B are connected in series between a voltage supply connected to current source 206A and the ground connected to current source 206B. Capacitor 504 is connected to the common node of current sources 206A-B and to ground. Capacitor 504 is designed to have a much lower capacitance than both capacitors 208A-B of the low pass filter. Transmission gate transistors 506A-B share a common input node with capacitor 504 and the common node of the current sources. The output node of the transmission gate is connected to capacitor 208A. Capacitor 208A is in turn connected by resistor 210 to ground. One terminal of capacitor 208B is connected to ground and the other terminal is connected to capacitor 208A and to the output node of transmission gates 506A-B. Comparator 522 has an input connected to the common node of current sources 206A-B. The other input of comparator 522 is connected to a voltage reference ladder comprising supply side resistor 516 and ground side resistor 518. The output of comparator 522 is connected to an input of OR gate 410. Comparator 528 has an input connected to the common node of current sources 206A-B. The other input of comparator 528 is connected to a voltage reference ladder comprising supply side resistor 524 and ground side resistor 526. The output of comparator 528 is connected to an input of OR gate 410. The output of OR gate 410 is connected both to an input of inverter 514 and to the gate of transmission gate transistor 506B. The output of inverter 514 is connected to the gate of transmission

-13-

gate 506A. The remaining input to OR gate 410 is connected to the output of monostable element 512. The input of monostable element 512 is connected to the output delay device 510. The input of delay device 510 is connected to the output of NOR gate 508.

5 In operation, the integer-N frequency synthesizer shown in Figs. 3-4 provides a range of frequencies F_s at the output node of VCO 112. The frequencies F_s provided by this circuit are all integer-N multiples of the reference frequency F_r . Phase detector 106 receives a variable frequency F_v from programmable divider 114, and a reference frequency F_r from generator 102. A string of pulses V_i ,
 10 corresponding to the instantaneous phase difference between F_v and F_r is output by the phase detector. As shown in Fig. 4, V_i may be provided on separate up/down-lines. If F_v falls before F_r , the down-line 204 will be asserted. If F_r falls before F_v , the up-line 202 will be asserted. If up-line 202 is asserted then current source 206A will add charge to capacitor 504. If down-line 204 is asserted then current source 206B
 15 will remove charge from capacitor 504. If the input signals F_v and F_r are in phase, i.e., phase lock, then the voltage V_p' corresponding to the charge on capacitor 504 will be constant. If the input signals F_v and F_r are not in phase, then V_p' will change accordingly to indicate the correction required in F_v to bring it back into lock with F_r . For example, if F_v has a lower frequency than F_r , up-line 202 will be periodically
 20 asserted and V_p' will rise. A rise in V_p' will translate into an increase in the frequency of the VCO and therefore of F_v . Conversely, if F_v is greater than F_r , down-line 204 will be periodically asserted and V_p' will fall. The fall in V_p' will translate into a decrease in the frequency of the VCO and therefore of F_v .

 The voltage on capacitor 504 V_p' would in conventional devices be
 25 continuously presented to VCO 112 via low pass filter 110. In conventional devices, every transition in V_p' would result in a corresponding transition in the output frequency F_s of VCO 112. An advantage of the current implementation, is that in

-14-

only two circumstances is the voltage on capacitor 504 presented to VCO 112 via low pass filter 110. The first instance is when the circuit is out of lock, the second instance is at discreet sampling intervals when the circuit is in lock. The current circuit can perform as a conventional device during an out of lock condition by presenting V_p' continuously to the VCO during acquisition and therefore minimizing lockup time. However, once lockup is achieved, the current implementation allows for sampling of V_p' and for presenting the sampled signal to the VCO. The sampled signal is far more stable than V_p' and this minimizes unnecessary modulation of F_v , caused by leakage, current source mismatch, or the fractional divide-by process.

When the circuit is out of lock, the output of phase detector 106 is a series of pulses on the up/down lines. The pulses are such as to always pull F_v toward F_r . When the synthesizer is out of lock, lockup time will be reduced by shorting V_p' directly to VCO 112 via low pass filter 110. Anti-saturation circuit 406 is provided to detect an out of lock condition and to short V_p' to VCO 112. There are several indicators of an out of lock condition. The anti-saturation circuit 406, as shown in Fig. 4 is sensitive to the voltage level of V_p' . When V_p' either exceeds an upper voltage threshold or is less than a lower voltage threshold, the anti-saturation circuit will enable OR gate 410, thereby closing transmission gates 506A-B, and shorting V_p' to the VCO. If F_v is less than F_r the up-line 202 will be asserted and charge will buildup on capacitor 504. When the voltage V_p' exceeds the upper voltage (V_{iu}) established by resistors 516-518 comparator 522 will be enabled. If F_v is greater than F_r the down-line 204 will be asserted and charge will be removed from capacitor 504. When the voltage V_p' drops below the lower voltage V_{il} established by resistors 524-526 comparator 528 will be enabled. As F_v moves in to a capture range, with respect to F_r , the voltage V_p' is centered between V_{iu} and V_{il} . Under this condition, neither comparator 522 nor 528 is enabled and the transmission gates will open. The system is then placed in a sampling mode in which the voltage V_p' will

-15-

be intermittently sampled, and the sampled voltage will be held on the input to the VCO.

With the system in lock, capacitor 502 will be shorted to the low pass filter 110, only when neither up-line 202 nor down-line 204 is enabled. Under these
5 circumstances NOR gate 508 will be enabled. After an appropriate interval established by delay 510, the monostable element 512 will enable OR gate 410 for a brief interval. During the enablement interval, the transmission gates 506A-B will connect capacitor 504 via low pass filter 110 to the VCO 112. The voltage level on V_p' is passed to the VCO via the low pass filter. At the end of the enablement
10 interval, switch control 408 will reopen the transmission gates. When the transmission gates are open, the capacitors 208A-B of the low pass filter hold the voltage level of V_p' imparted to the low pass filter during the prior enablement interval.

In an alternate embodiment, anti-saturation circuit 406 could determine an out
15 of lock threshold by detecting changes in the duty cycle of the up/down pulses from the phase detector V_i or the charge pump V_c . When the PLL is in lock, the duty cycle for a phase indicating signal such as V_i , is typically less than 1-in-10. When the PLL is out of lock, the duty cycle is on the order of 1-in-2. The anti-saturation circuit can be constructed to detect an out of lock condition corresponding to a duty
20 cycle of greater than 1-in-10. Once this condition has been detected, the anti-saturation circuit 406 is enabled and sampler 404 is closed to prevent saturation of capacitor 504 with the associated degradation of acquisition time.

The benefits of sampling the voltage V_p' on capacitor 504 rather than continuously presenting it to VCO 112 are twofold. First, spurious sidebands
25 introduced by leakage are reduced. The leakage path from the charge pump 108 to the low pass filter 110, is through the transmission gate transistors 506A-B of the sampler 404. These are in an open circuit condition, and thereby prevent leakage,

-16-

for a substantial portion of each divide-by-N cycle. Second, spurious sidebands introduced by current source mismatch or the fractional division process itself are reduced. The AC ripple that would be introduced by current source mismatch or the fractional division process is avoided by ensuring that the transmission gate are used to sample V_p' periodically at times when it is relatively stable and the charge pump 108 is inactive. This prevents the introduction of transient currents that could otherwise be injected into the low pass filter 110 and results in a signal V_i which approaches a purely DC level.

Fig. 5A-D shows waveforms for the integer-N synthesizer embodiment shown in Figs. 3-4. Four waveforms are shown. Fig. 5A shows V_p' , the voltage present on the capacitor 504. Fig. 5B shows V_c , which represents voltage on the common node of current sources 206A-B under an open circuit condition. Fig. 5C shows V_s , the output of OR gate 410 during phase lock. Fig. 5D shows V_i , the tuning voltage present on the input of VCO 112.

V_p' is shown with a sawtooth waveform corresponding to leakage or device mismatch in current sources 206A-B. A peak voltage 800 and a subsequent valley 802 are referenced. V_c is shown with multiple voltage pulses of which 804 and 806 are referenced. Voltage pulse 804 corresponds in time to the transition from a voltage valley to the referenced peak voltage 800 on V_p' . V_s is also shown with multiple voltage pulses of which 808 is referenced. The voltage pulses are uniformly delayed in time from those shown on V_c . Voltage pulse 808 occurs during a null period between voltage pulses 804 and 806 on V_c . V_i is primarily DC in nature. There are long intervals of absolute DC level of which voltage 810 is referenced. This DC signal has modest ripples of which voltage 812 is referenced. The voltage level shown on V_i corresponds roughly to the average voltage of the sawtooth waveform V_p' . The advantage of the current invention is that by sampling V_p' rather than presenting directly to VCO 112, a voltage level that more closely approaches a

-17-

DC value can be achieved. Because the sampler is closed once during each cycle of the integer-N divide-by process, V_p' will be sampled at times when its voltage is constant. This eliminates unwanted modulation of the VCO and therefore of F_s .

In contrast to an integer-N synthesizer, in which frequency steps are integer multiples of the reference frequency, fractional-N synthesizers can produce
5 synthesized frequencies which are fractional multiples of the reference frequency. Typically a fractional-N synthesizer cyclically changes the divide-by ratio of the programmable VCO divider between different integer values on successive comparison cycles of the phase detector. Over each complete divide-by cycle, the
10 average frequency approaches the fractional average of the integer denominators. For example, a divide-by-N+0.5 can be produced by using an integer-N divider and dividing-by N on one cycle and N+1 on the next. On average this is equivalent to dividing by N+0.5 on both cycles.

Fig. 6 is an illustrative block diagram of a presently preferred embodiment of
15 a fractional-N phase locked frequency synthesizer. The circuit comprises a reference frequency generator 102, a difference circuit, a sampling circuit, a VCO 112 and a divider circuit. In the current embodiment, the difference circuit comprises a phase detector 106, a charge pump 108 and an integrator 402. The sampling circuit
20 comprises a sampler 404 an anti-saturation circuit 406, an OR gate 410, a switch control 612 and a low pass filter 110. The divider circuit comprises a fractional control logic 600 and a programmable divider 114.

The phase detector 106 has a first input connected to the output of programmable divider 114 and a second input connected to the output of reference
25 signal generator 102. The output of phase detector 106 is connected both to the input of charge pump 108 and to an input of switch control 612. Additionally, the output of phase detector 106 may be connected to an input of anti-saturation circuit 406. The output of charge pump 108 is connected to the input of integrator 402.

-18-

The output of integrator 402 is connected both to an input of anti-saturation circuit 406 and to an input of sampler 404. The output of anti-saturation circuit 406 is connected to an input of OR gate 410. The output of OR gate 410 is connected to the control input of sampler 404. The remaining input to OR gate 410 is connected to the output of switch control 612. The output of sampler 404 is connected to the input of low pass filter 110. The output of low pass filter 110 is connected to the input of VCO 112. The output of VCO 112 is connected to the input of programmable divider 114. The output of fractional control logic 600 is connected to both an input of switch control 612 and an input of programmable divider 114. The output of programmable divider 114 is connected to both the input of fractional control logic 600 and to the phase detector 106.

In an alternative embodiment, the programmable divider 114 is instead connected between the reference signal generator 102 and the phase detector 106. The output of the programmable divider, is connected to the second input of the phase detector 106. The first input of the phase detector is connected to the output of the VCO 112. The output of fractional control logic 600 is connected to both an input of switch control 612 and an input of programmable divider 114.

Fig. 7 is an illustrative drawing, partially at gate level and partially at a block diagram level of switch control 612 of Fig. 6. Switch control 612 comprises a cycle detect 700, an AND gate 702, a delay 510 and a monostable element 512. The input of cycle detect 700 is connected to the output of fractional control logic 600. The output of cycle detect 700 is connected to an input of AND gate 702. The inputs of NOR gate 508 are the same as those discussed above in connection with Fig. 4 connected to the up-line 202 and down-line 204 of phase detector 106. The output of NOR gate 508 is connected to the remaining input of AND gate 702. The output of AND gate 702 is connected to the input of delay 510. The output of delay 510 is connected to the input of monostable element 512. The output of monostable

-19-

element 512 is as discussed above in connection with Fig. 4 connected to an input of OR gate 410.

In operation, the switch control 612 requires that both a null condition exist on the output of phase detector 106 and that a new cycle be initiated by fractional control logic 600. When both these conditions are detected AND gate 702 will be enabled. After an appropriate interval corresponding to delay 510, monostable element 512 will be triggered for a brief interval of time thereby enabling the output of OR gate 410. In connection with Figs. 3-4, the enabled OR gate output condition shorts capacitor 504 to VCO 112 via low pass filter 110. When the switch is not enabled the capacitors 208A-B hold the charge imparted during the prior enablement.

In an alternate embodiment, the switch control 612 would have logic that responded only to a new cycle being initiated by fractional control logic 600. In this embodiment OR gate 410 would be enabled at an appropriate delay after a new cycle was initiated by the fractional control logic.

Fig. 8A-D exhibits waveforms for the fractional-N synthesizer embodiment of Figs. 6-7. Fig. 8A shows V_d , the output of fractional control logic 600. V_d is an input for both switch control 612 and programmable divider 114. Fig. 8B shows V_p , the voltage present on capacitor 504. Fig. 8C shows V_s , the output of OR gate 410. Fig. 8D shows V_t , the tuning voltage applied to VCO 112. The waveform V_d is typical of conventional fractional control logic output. In this example, the integer denominator $N+1$ is presented to the programmable divider once in every six cycles. By dividing the VCO output in this cyclic fashion the value for F_s is produced which is a fractional multiple of F_r . If for example $N = 10$, then in the example shown $F_s = 10.17 \times F_r$. Depending on the periodicity of V_d and the value of N a range of fractional values for F_s can be obtained. The techniques for achieving this fractional control are well known to those skilled in the art and are discussed in connection with the above-mentioned patents which have been incorporated by reference.

-20-

As is shown on V_p' , the fractional-N process produces multiple abrupt changes in V_p' . The example begins with an N+1 signal 900 present on V_d . This corresponds to an abrupt reduction in the output frequency F_v of programmable divider 114. The reduction in frequency of F_v corresponding to an increase in the denominator applied by the programmable divider to F_s from N to N+1. In response V_p' which had been at a low voltage level 908 increases abruptly to an intermediate voltage 910. The increase in voltage level V_p' corresponds to the first indication from the phase detector 106 that the frequency of the VCO 112 needs to be increased to bring F_v back into phase with F_r . However, at the same time that V_p' rises, the fractional control logic 600 has altered V_d to a divide-by-N signal 902 thereby immediately increasing the output frequency F_v of the programmable divider 114. As a result of these complimentary indications, the circuit initially over responds and V_p' transitions to a high voltage 912. As successive divide-by-N cycles are presented by the fractional control logic 600, the circuit corrects for the over response and the voltage V_p' decreases to an intermediate voltage 914 and to a low voltage 916. No sooner has low voltage 916 occurred, than a divide-by-N+1 signal 904 is again present on V_d . The divide-by-N+1 corresponds to an abrupt slow down in F_v which causes a subsequent rise in V_p' to intermediate voltage 918. The divide-by cycle repeats itself with the signal on V_d then transitioning to a divide-by-N signal 906.

In the conventional fractional-N synthesizers, V_p' would be presented continuously to the VCO and as a result, the VCO output F_s would wander through frequency regimes represented by the different voltage levels present on V_p' . This would tend to degrade the accuracy of the fractional-N synthesis because F_s would vary also. A teaching of the current invention is that it is preferable, when the circuit is in lock, to sample V_p' once per cycle, and thereby present a uniform DC voltage V_i to the VCO. This avoids unnecessary modulation of F_s .

-21-

As is shown in Fig. 8C, V_s has two voltage pulses 924 and 926 occurring at a time identical to the occurrence of intermediate voltages 910 and 918 on V_p' . Intermediate voltages 910 and 918 are the voltages which need to be applied to the VCO to keep it at the fractional frequency $F_s = 10.17 \times F_r$. Voltages 908, 912, 916 will produce VCO frequencies which are above or below the desired fractional relationship. As shown in Fig. 8D, V_i is primarily a DC waveform with only two minor voltage ripples 928 and 930. The voltage level of V_i corresponds to the voltages on V_p' which are sampled and held, and of which 910 and 918 are referenced in Fig. 8B.

As described above, according to the apparatus and method to reduce the spurious sidebands in phase locked loops of this invention, the effect of spurious sidebands at the critical node can be reduced to provide improved tracking capability in PLLs and PLL synthesizers of either the integer-N or fractional-N type.

The foregoing description of a preferred embodiment of the invention has been presented for purposes of illustration and description. It is not intended to be exhaustive or to limit the invention to the precise forms disclosed. Obviously, many modifications and variations will be apparent to practitioners skilled in this art. It is intended that the scope of the invention be defined by the following claims and their equivalents.

-22-

What is claimed is:

1. A frequency synthesizer, comprising:
 - an oscillator for producing a variable frequency oscillator signal in response
 - 5 to an applied tuning signal;
 - a divider circuit which divides by a division factor and communicating with said oscillator to receive and divide said variable frequency oscillator signal by said division factor to produce a reduced frequency signal;
 - a difference circuit to receive an applied reference signal and to communicate
 - 10 with said divider circuit to receive said reduced frequency signal to produce a difference signal, such that the difference signal corresponds to a phase difference of the reference signal and the reduced frequency signal; and
 - a sample circuit which samples the difference signal in response to an applied timing signal to produce the tuning signal.
 - 15
2. The frequency synthesizer of claim 1, wherein said difference circuit further comprises:
 - a phase comparator to receive the reference signal and the reduced frequency
 - signal to produce the timing signal, such that the timing signal corresponds to an
 - 20 instantaneous phase difference of the reference signal and the reduced frequency signal; and
 - an integrator to receive and integrate the timing signal to produce the difference signal.
- 25 3. The frequency synthesizer of claim 2, wherein said sample circuit further comprises:
 - a null detect circuit to receive the timing signal, to detect a null in the timing

-23-

signal and to produce a control signal; and

a hold circuit responsive to the control signal to hold a voltage level of the difference signal and produce a tuning signal, corresponding to the held voltage level of the difference signal.

5

4. The frequency synthesizer of claim 1, wherein said sample circuit further comprises:

an antisaturation circuit to receive the difference signal, to detect a threshold condition on said difference signal, and to produce a lock signal; and

10

said sample circuit samples the difference signal in response to the applied timing signal and the lock signal to produce the tuning signal.

5. The frequency synthesizer of claim 1, wherein:

said divider circuit further comprises;

15

a) a fractional control to cyclically alter at least two division factors to produce the timing signal; and

b) a fractional divider to divide said variable frequency oscillator signal by the timing signal to produce the reduced frequency signal which is a non-integer fraction of said oscillator signal; and

20

said sample circuit further comprises;

a) a hold circuit responsive to a cyclic alteration in the timing signal to hold a voltage level of the difference signal and to produce the tuning signal corresponding to the held voltage level of the difference signal.

25

6. A phase locked loop, comprising:

an oscillator for producing a variable frequency oscillator signal in response

-24-

to an applied tuning signal;

a difference circuit to receive an applied reference signal and to communicate with said oscillator to receive said oscillator signal to produce a difference signal, such that the difference signal corresponds to a phase difference of the reference signal and the oscillator signal; and

a sample circuit which samples the difference signal in response to an applied timing signal to produce the tuning signal.

7. The phase locked loop of claim 6, wherein said difference circuit further comprises:

a phase comparator to receive the reference signal and the oscillator signal to produce the timing signal, such that the timing signal corresponds to an instantaneous phase difference of the reference signal and the oscillator signal; and

an integrator to receive and integrate the timing signal to produce the difference signal.

8. The phase locked loop of claim 7, wherein said sample circuit further comprises:

a null detect circuit to receive the timing signal, to detect a null in the timing signal and to produce a control signal; and

a hold circuit responsive to the control signal to hold a voltage level of the difference signal and produce a tuning signal, corresponding to the held voltage level of the difference signal.

9. The phase locked loop of claim 6, wherein said sample circuit further comprises:

an antisaturation circuit to receive the difference signal, to detect a threshold

-25-

condition on said difference signal, and to produce a lock signal; and

said sample circuit samples the difference signal in response to the applied timing signal and the lock signal to produce the tuning signal.

5 10. A frequency synthesizer, comprising:

an oscillator comprising an input lead and an output lead, responsive to a tuning signal on said input lead to vary the frequency of an oscillator signal at the output lead;

10 a divider comprising an input lead coupled to the output lead of the oscillator and an output lead, responsive to the oscillator signal at the divider input lead to generate a reduced frequency signal at the divider output lead;

15 a difference circuit comprising a first input lead coupled to the output lead of the divider, a second input lead and an output lead, responsive to the reduced frequency signal on the difference circuit first input lead and a reference signal on the difference circuit second input lead to generate a difference signal at the difference circuit output lead, such that said difference signal corresponds to a phase difference of the reference signal and the reduced frequency signal; and

20 a sample circuit comprising a first input lead coupled to the output lead of the difference circuit, an output lead coupled to the input lead of the oscillator, and a second input lead responsive to a timing signal to sample the difference signal on the first input lead of the sample circuit and generate the tuning signal on the sample circuit output lead.

25 11. The frequency synthesizer of claim 10, wherein:

said difference circuit further comprises:

a) a phase comparator comprising first and second input leads coupled to the first and second input leads of the difference circuit and an output lead coupled to the

-26-

second input lead of the sample circuit, and responsive to the reduced frequency signal on the difference circuit first input lead and the reference signal on the difference circuit second input lead to generate the timing signal at said phase comparator output lead, such that the timing signal corresponds to an instantaneous phase difference of the reference signal and the reduced frequency signal; and

b) an integrator comprising an input lead coupled to the output lead of the phase comparator and an output lead coupled to the output lead of the difference circuit and responsive to the timing signal at the integrator input lead to integrate the timing signal and to generate the difference signal at the difference circuit output lead.

12. The frequency synthesizer of claim 11, wherein said sample circuit further comprises:

a) a null detect circuit comprising an input lead coupled to said second input lead of said sample circuit and an output lead, responsive to a null in the timing signal on the null detect circuit input lead to generate a control signal at the output lead of the null detect circuit; and

b) a hold circuit comprising a first input lead coupled to the output lead of the null detect circuit, a second input lead coupled to the first input lead of the sample circuit and an output lead coupled to the output lead of the sample circuit, responsive to the control signal on the first input lead of the hold circuit to sample a voltage level of the difference signal at the second input lead of the hold circuit, to hold the sampled voltage level, and to generate the tuning signal on the hold circuit output lead, whereby the tuning signal corresponds to the held voltage level of the difference signal.

13. The frequency synthesizer of claim 10, wherein said sample circuit further comprises:

-27-

an antisaturation circuit comprising an input lead coupled to the first input lead of the sample circuit and an output lead coupled to the second input lead of the sample circuit, and responsive to a threshold condition on the difference signal on the input of the antisaturation circuit to generate a lock signal on the output of the antisaturation circuit; and

the sample circuit is further responsive to both the timing signal and the lock signal on the sample circuit second input lead, to sample the difference signal on the first input lead of the sample circuit and generate the tuning signal on the sample circuit output lead.

14. The frequency synthesizer of claim 10, wherein:
said divider further comprises;

a) a fractional divider comprising, a first input lead coupled to the input lead of the divider, an output lead coupled to the output lead of the divider and a second input lead, responsive to the oscillator signal at the frequency reducer input lead and a timing signal at the second input lead of the fractional divider to divide the oscillator signal by the timing signal and generate the reduced frequency signal at the divider output lead; and

b) a fractional control logic comprising an input lead coupled to the output lead of the divider and an output lead coupled to both the second input lead of the fractional divider and the second input lead of the sample circuit, responsive to the reduced frequency signal at the fractional control logic input lead to cyclically alter at least two division factors to produce the timing signal at the fractional control logic output lead, whereby said reduced frequency signal is a non-integer fraction of said oscillator signal; and

the sample circuit further comprises;

a) a cyclic detect circuit comprising an input lead coupled to said second input

-28-

lead of said sample circuit and an output lead, responsive to a cyclic alteration in the timing signal on the cyclic detect circuit input lead to generate a control signal at the output lead of the cyclic detect circuit; and

- 5 b) a hold circuit comprising a first input lead coupled to the output lead of the cyclic detect circuit, a second input lead coupled to the first input lead of the sample circuit and an output lead coupled to the output lead of the sample circuit, responsive to the control signal on the first input lead of the hold circuit to sample a voltage level of the difference signal at the second input lead of the hold circuit, to hold the sampled voltage level, and to generate the tuning signal on the hold circuit output
10 lead, whereby the tuning signal corresponds to the held voltage level of the difference signal.

- 15 15. A phase locked loop, comprising:
 an oscillator comprising an input lead and an output lead, responsive to a
15 tuning signal on said input lead to vary the frequency of an oscillator signal at the output lead;
 a difference circuit comprising a first input lead coupled to the output lead of the oscillator, a second input lead and an output lead, responsive to the oscillator signal on the difference circuit first input lead and a reference signal on the difference
20 circuit second input lead to generate a difference signal at the difference circuit output lead, such that the difference signal corresponds to a phase difference of the reference signal and the reduced frequency signal; and
 a sample circuit comprising a first input lead coupled to the output lead of the difference circuit, an output lead coupled to the input lead of the oscillator, and a
25 second input lead responsive to a timing signal to sample the difference signal on the first input lead of the sample circuit and generate the tuning signal on the sample circuit output lead.

-29-

16. The phase locked loop of claim 15, wherein said difference circuit further comprises:

- 5 a) a phase comparator comprising first and second input leads coupled to the first and second input leads of the difference circuit and an output lead coupled to the second input lead of the sample circuit, and responsive to the oscillator signal on the difference circuit first input lead and the reference signal on the difference circuit second input lead to generate the timing signal at said phase comparator output lead, such that the timing signal corresponds to an instantaneous phase difference of the reference signal and the oscillator signal; and
- 10 b) an integrator comprising an input lead coupled to the output lead of the phase comparator and an output lead coupled to the output lead of the difference circuit and responsive to the timing signal at the integrator input lead to integrate the timing signal and to generate the difference signal at the difference circuit output lead.

15 17. The phase locked loop of claim 16, wherein said sample circuit further comprises:

- 20 a) a null detect circuit comprising an input lead coupled to the second input lead of the sample circuit and an output lead, responsive to a null in the timing signal on the null detect circuit input lead to generate a control signal at the output lead of the null detect circuit; and
- 25 b) a hold circuit comprising a first input lead coupled to the output lead of the null detect circuit, a second input lead coupled to the first input lead of the sample circuit and an output lead coupled to the output lead of the sample circuit, responsive to the control signal on the first input lead of the hold circuit to sample a voltage level of the difference signal at the second input lead of the hold circuit, to hold the sampled voltage level, and to generate the tuning signal on the hold circuit output lead, whereby the tuning signal corresponding to the held voltage level of the

-30-

difference signal.

18. The phase locked loop of claim 15, wherein said sample circuit further comprises:

5 an antisaturation circuit comprising an input lead coupled to the first input lead of the sample circuit and an output lead coupled to the second input lead of the sample circuit, and responsive to a threshold condition on the difference signal on the input of the antisaturation circuit to generate a lock signal on the output of the antisaturation circuit; and

10 said sample circuit second input lead is responsive to both the timing signal and the lock signal on the sample circuit second input lead, to sample the difference signal on the first input lead of the sample circuit and generate the tuning signal on the sample circuit output lead.

15 19. A method for operating a frequency synthesizer, comprising:

 generating an oscillator signal having a frequency corresponding to an applied tuning signal;

 dividing the oscillator signal by a division factor to generate a reduced frequency signal;

20 combining a reference signal and the reduced frequency signal to generate a difference signal proportional to a phase difference between the reference signal and the reduced frequency signal; and

 sampling the difference signal in response to an applied timing signal to produce the tuning signal.

25

20. The method of claim 19, wherein the step of combining further comprises:

a) detecting an instantaneous phase difference between the reference signal and

-31-

the reduced frequency signal to generate the timing signal; and

b) integrating the timing signal to produce the difference signal.

21. The method of claim 20, wherein the step of sampling further comprises:

- 5 a) detecting a null in the timing signal to generate a control signal; and
b) sampling the difference signal in response to the control signal to generate the tuning signal.

22. The method of claim 19, wherein the step of sampling further comprises:

- 10 a) detecting a threshold condition on the difference signal, and generating a lock signal; and
b) sampling the difference signal in response to the applied timing signal and the lock signal to generate the tuning signal.

15 23. The method of claim 19, wherein:

the step of dividing further comprises;

- a) generating the timing signal corresponding to the cyclic alteration of at least two division factors; and
b) dividing the oscillator signal by the timing signal to generate the reduced
20 frequency signal, such that the reduced frequency signal is a non-integer fraction of the oscillator signal; and
the step of sampling further comprises;
a) detecting a cyclic alteration in the timing signal to generate a control signal;
b) holding a sampled voltage level of the difference signal in response to the
25 applied control signal; and
c) generating a tuning signal corresponding to the held voltage level of the difference signal.

-32-

24. A method for operating a phase locked loop, comprising:
generating an oscillator signal having a frequency corresponding to an applied tuning signal;
combining a reference signal and the oscillator signal to generate a difference
5 signal proportional to a phase difference between the reference signal and the oscillator signal; and
sampling the difference signal in response to an applied timing signal to produce the tuning signal.
- 10 25. The method of claim 24, wherein the step of combining further comprises:
detecting an instantaneous phase difference between the reference signal and the oscillator signal to generate the timing signal; and
integrating the timing signal to produce the difference signal.
- 15 26. The method of claim 25, wherein the step of sampling further comprises:
detecting a null in the timing signal to generate a control signal; and
sampling the difference signal in response to the control signal to generate the tuning signal.
- 20 27. The method of claim 24, wherein the step of sampling further comprises:
detecting a threshold condition on the difference signal, and producing a lock signal; and
sampling the difference signal in response to the timing signal and the lock
signal to generate the tuning signal.
- 25 28. A difference circuit, comprising:
a phase comparator to receive a first signal and second signal to produce an

-33-

instantaneous phase difference signal, such that the instantaneous phase difference signal corresponds to an instantaneous phase difference of the first and the second signal; and

5 an integrator to receive and integrate the instantaneous phase difference signal to produce a difference signal;

 a sample circuit which samples a voltage level of the difference signal in response to an applied timing signal; and

 a hold circuit to hold the sampled voltage level of the difference signal and produce a tuning signal, corresponding to the held voltage level of the difference signal.

10

29. The difference circuit of claim 28, wherein said timing signal corresponds to a null in said instantaneous phase difference signal.

15 30. The difference circuit of claim 28, further comprising;
 an oscillator for producing a first signal having a frequency varying in response to the applied tuning signal.

20 31. A method for operating a difference circuit, comprising:
 combining a first signal and second signal to generate an instantaneous phase difference signal, such that the instantaneous phase difference signal corresponds to an instantaneous phase difference of the first and the second signal; and
 integrating the instantaneous phase difference signal to produce a difference signal;
25 sampling a voltage level of the difference signal in response to an applied timing signal; and
 holding the sampled voltage level of the difference signal; and

-34-

generating a tuning signal, corresponding to the held voltage level of the difference signal.

32. The method of claim 31 wherein the step of sampling further comprises:

- 5 a) detecting a null in the timing signal to generate a control signal; and
 b) sampling a voltage level of the difference signal in response to the control signal.

33. The method of claim 31, further comprising:

- 10 generating the second signal having a frequency corresponding to the applied tuning signal..

34. A frequency synthesizer, comprising:

- 15 an oscillator for producing a variable frequency oscillator signal in response to an applied tuning signal;

 a divider circuit which divides by a division factor and communicating with a reference signal source to divide a reference signal by said division factor to produce a reduced frequency signal;

- 20 a difference circuit to receive an applied variable frequency oscillator signal and to communicate with said divider circuit to receive said reduced frequency signal to produce a difference signal, such that the difference signal corresponds to a phase difference of the reference signal and the reduced frequency signal; and

 a sample circuit which samples the difference signal in response to an applied timing signal to produce the tuning signal.

25

35. The frequency synthesizer of claim 34, wherein said difference circuit further comprises:

-35-

a phase comparator to receive the variable frequency oscillator signal and the reduced frequency signal to produce the timing signal, such that the timing signal corresponds to an instantaneous phase difference of the variable frequency oscillator signal and the reduced frequency signal; and

5 an integrator to receive and integrate the timing signal to produce the difference signal.

36. The frequency synthesizer of claim 35, wherein said sample circuit further comprises:

10 a null detect circuit to receive the timing signal, to detect a null in the timing signal and to produce a control signal; and

 a hold circuit responsive to the control signal to hold a voltage level of the difference signal and produce a tuning signal, corresponding to the held voltage level of the difference signal.

15

37. The frequency synthesizer of claim 34, wherein said sample circuit further comprises:

 an antisaturation circuit to receive the difference signal, to detect a threshold condition on said difference signal, and to produce a lock signal; and

20 said sample circuit samples the difference signal in response to the applied timing signal and the lock signal to produce the tuning signal.

38. The frequency synthesizer of claim 34, wherein:

 said divider circuit further comprises;

25 a) a fractional control to cyclically alter at least two division factors to produce the timing signal; and

 b) a fractional divider to divide said variable frequency oscillator

-36-

signal by the timing signal to produce the reduced frequency signal which is a non-integer fraction of said reference signal; and
said sample circuit further comprises;

- 5 a) a hold circuit responsive to a cyclic alteration in the timing signal to hold a voltage level of the difference signal and to produce the tuning signal corresponding to the held voltage level of the difference signal.

- 10 39. A method for operating a frequency synthesizer, comprising:
generating an oscillator signal having a frequency corresponding to an applied tuning signal;
dividing a reference signal by a division factor to generate a reduced frequency signal;
15 combining the oscillator signal and the reduced frequency signal to generate a difference signal proportional to a phase difference between the oscillator signal and the reduced frequency signal; and
sampling the difference signal in response to an applied timing signal to produce the tuning signal.

- 20 40. The method of claim 39, wherein the step of combining further comprises:
a) detecting an instantaneous phase difference between the oscillator signal and the reduced frequency signal to generate the timing signal; and
b) integrating the timing signal to produce the difference signal.

- 25 41. The method of claim 40, wherein the step of sampling further comprises:
a) detecting a null in the timing signal to generate a control signal; and
b) sampling the difference signal in response to the control signal to generate the

-37-

tuning signal.

42. The method of claim 39, wherein the step of sampling further comprises:

- 5 a) detecting a threshold condition on the difference signal, and generating a lock signal; and
- b) sampling the difference signal in response to the applied timing signal and the lock signal to generate the tuning signal.

43. The method of claim 39, wherein:

10 the step of dividing further comprises;

- a) generating the timing signal corresponding to the cyclic alteration of at least two division factors; and
- b) dividing the reference signal by the timing signal to generate the reduced frequency signal, such that the reduced frequency signal is a non-integer fraction of
- 15 the reference signal; and
- the step of sampling further comprises;
- a) detecting a cyclic alteration in the timing signal to generate a control signal;
- b) holding a sampled voltage level of the difference signal in response to the applied control signal; and
- 20 c) generating a tuning signal corresponding to the held voltage level of the difference signal.

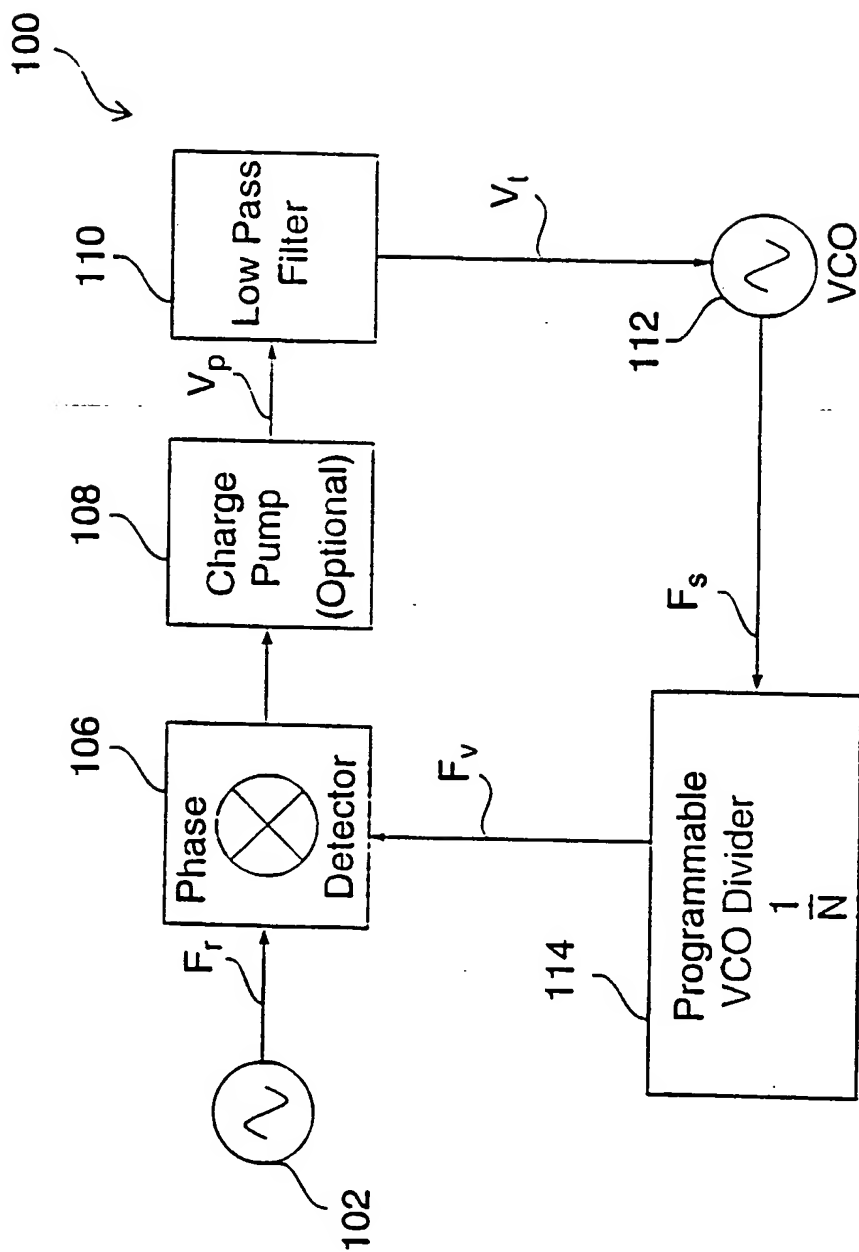


Fig. 1
(Prior Art)

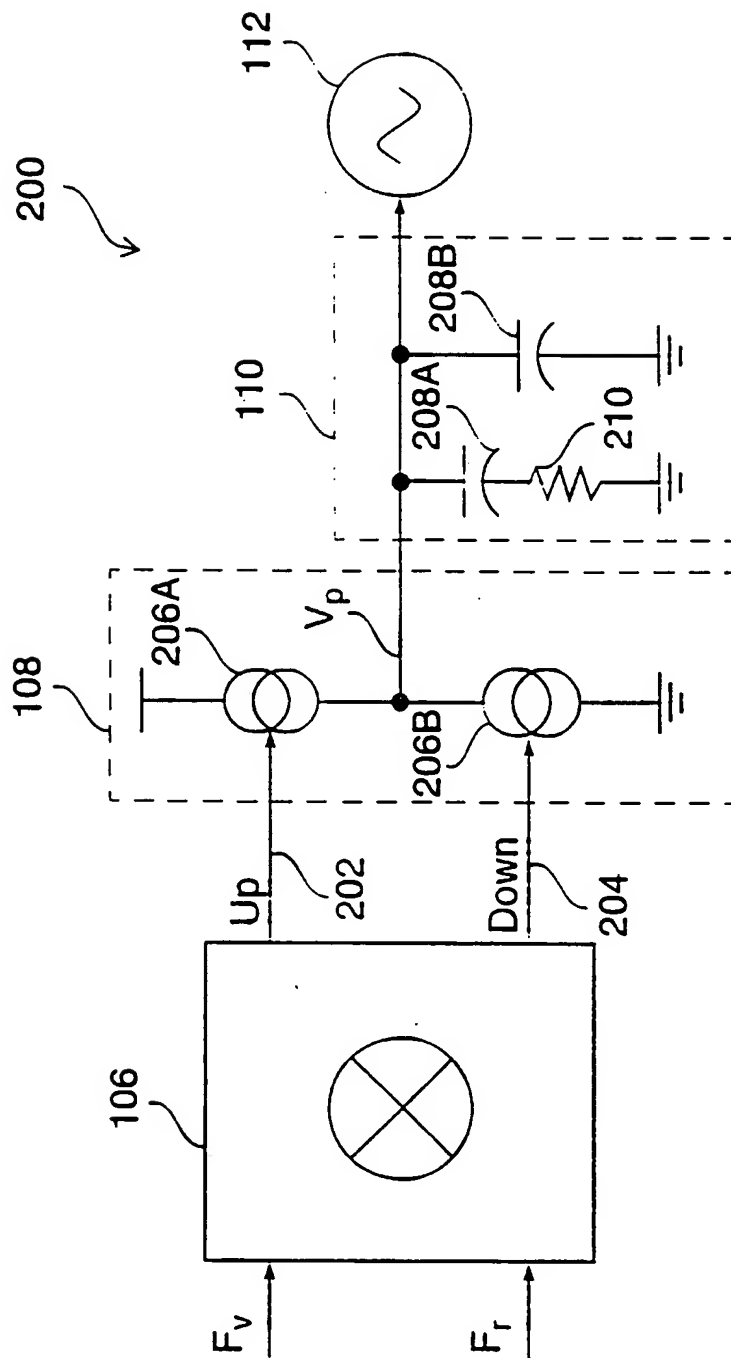


Fig. 2
(Prior Art)

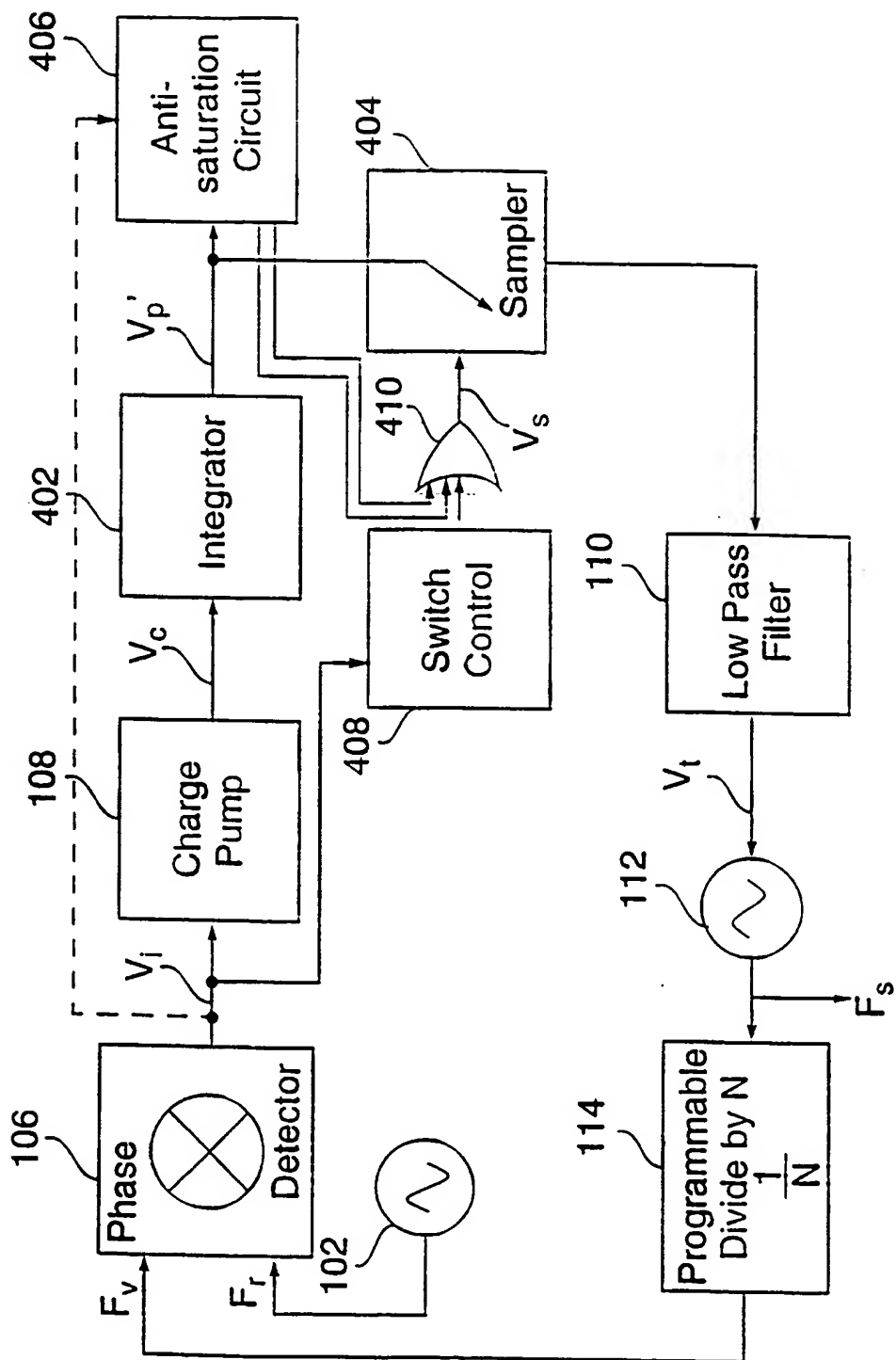


Fig. 3

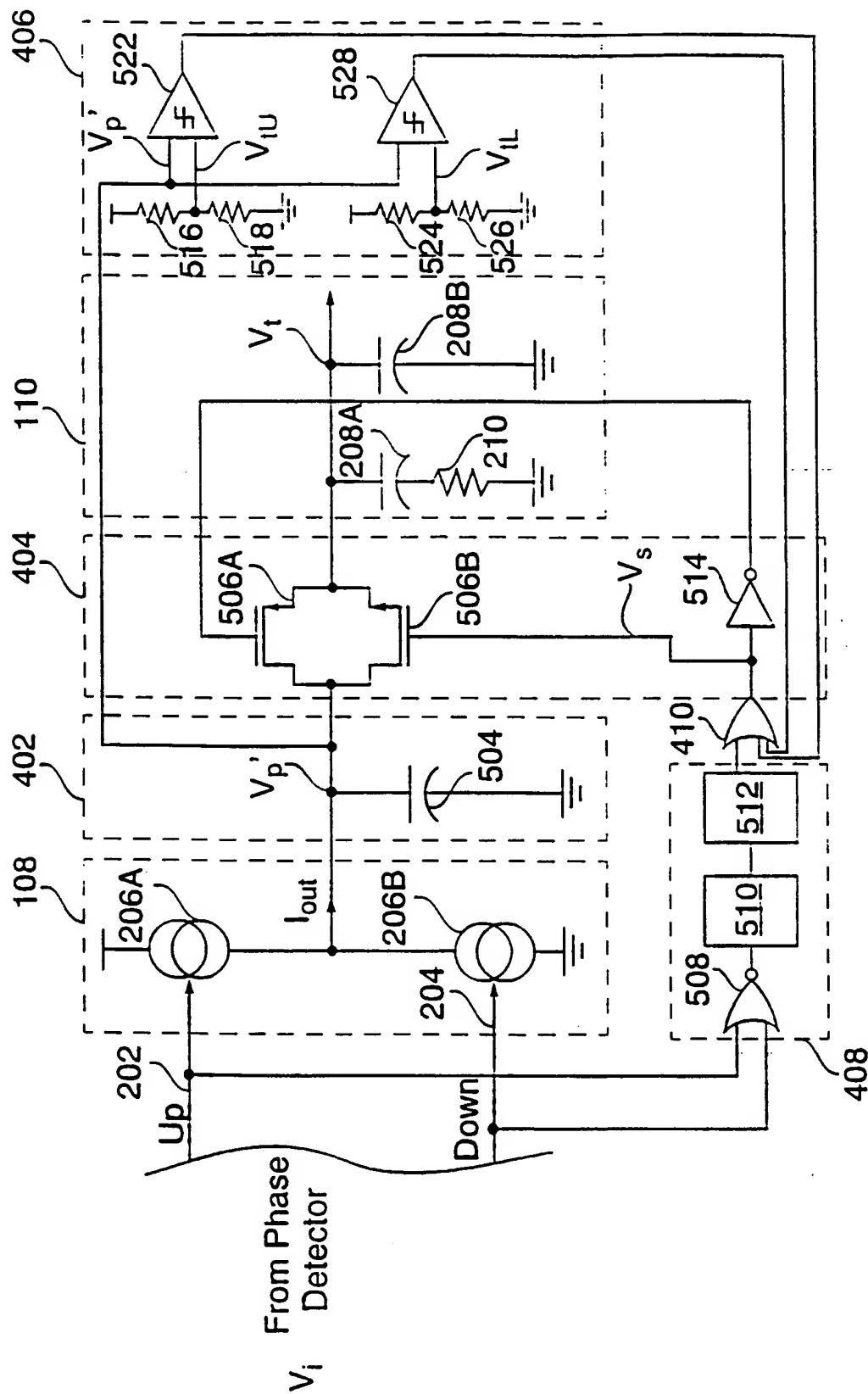
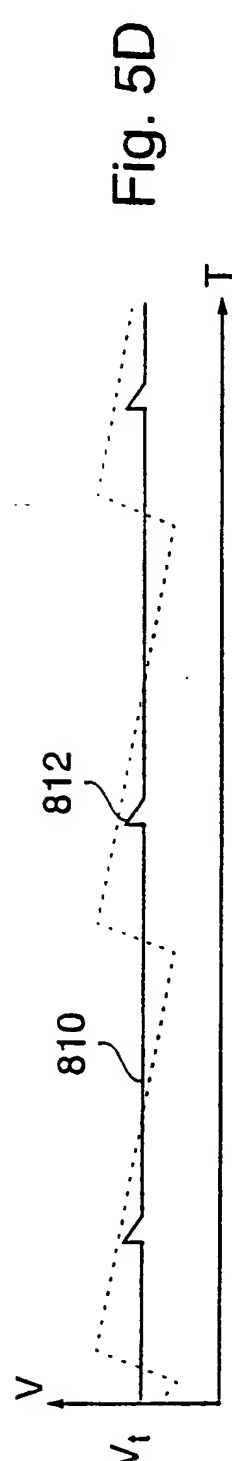
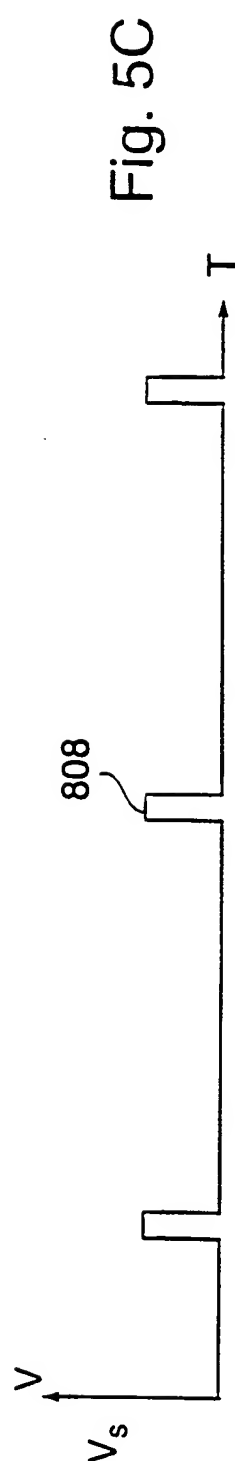
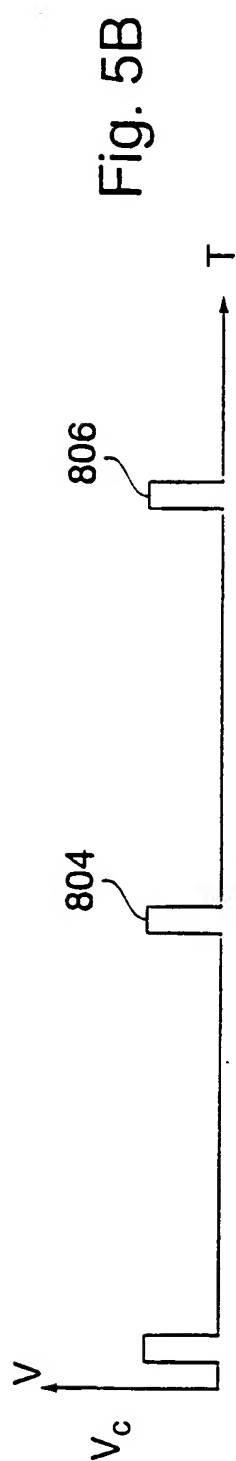
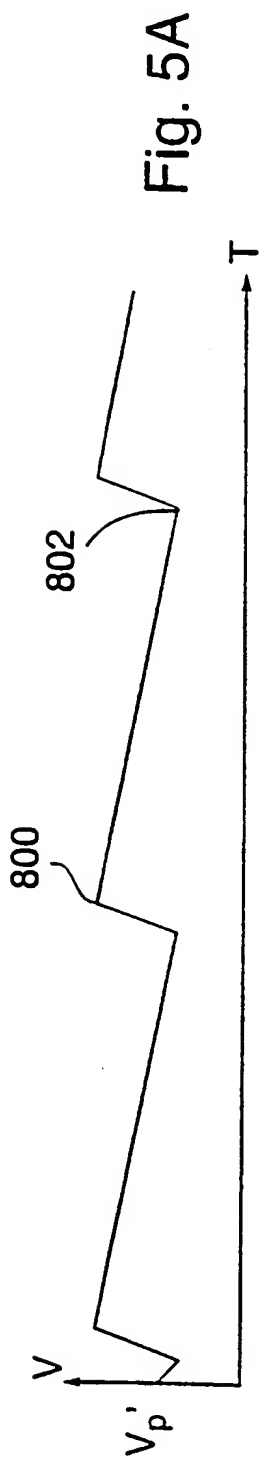


Fig. 4



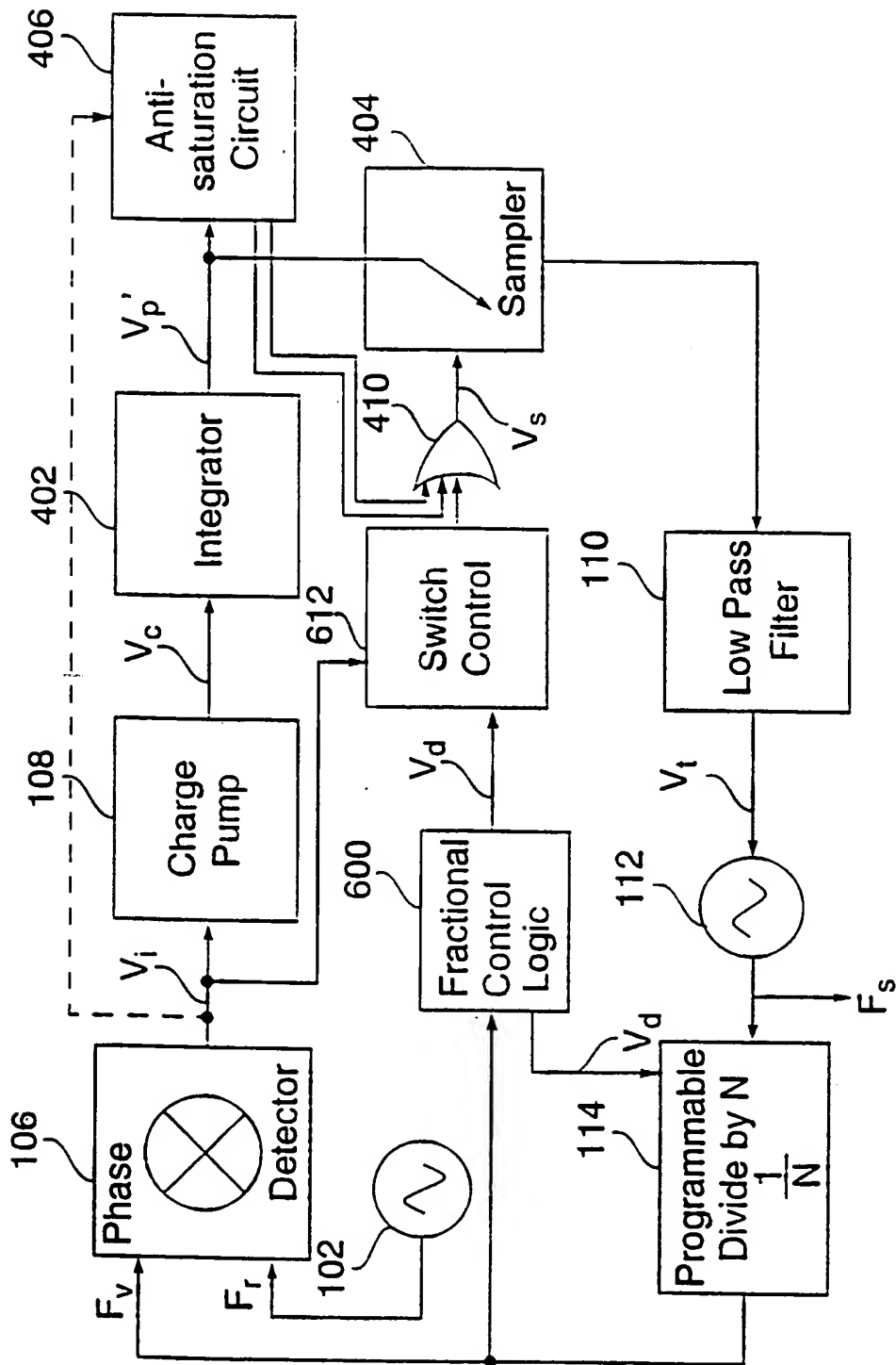


Fig. 6

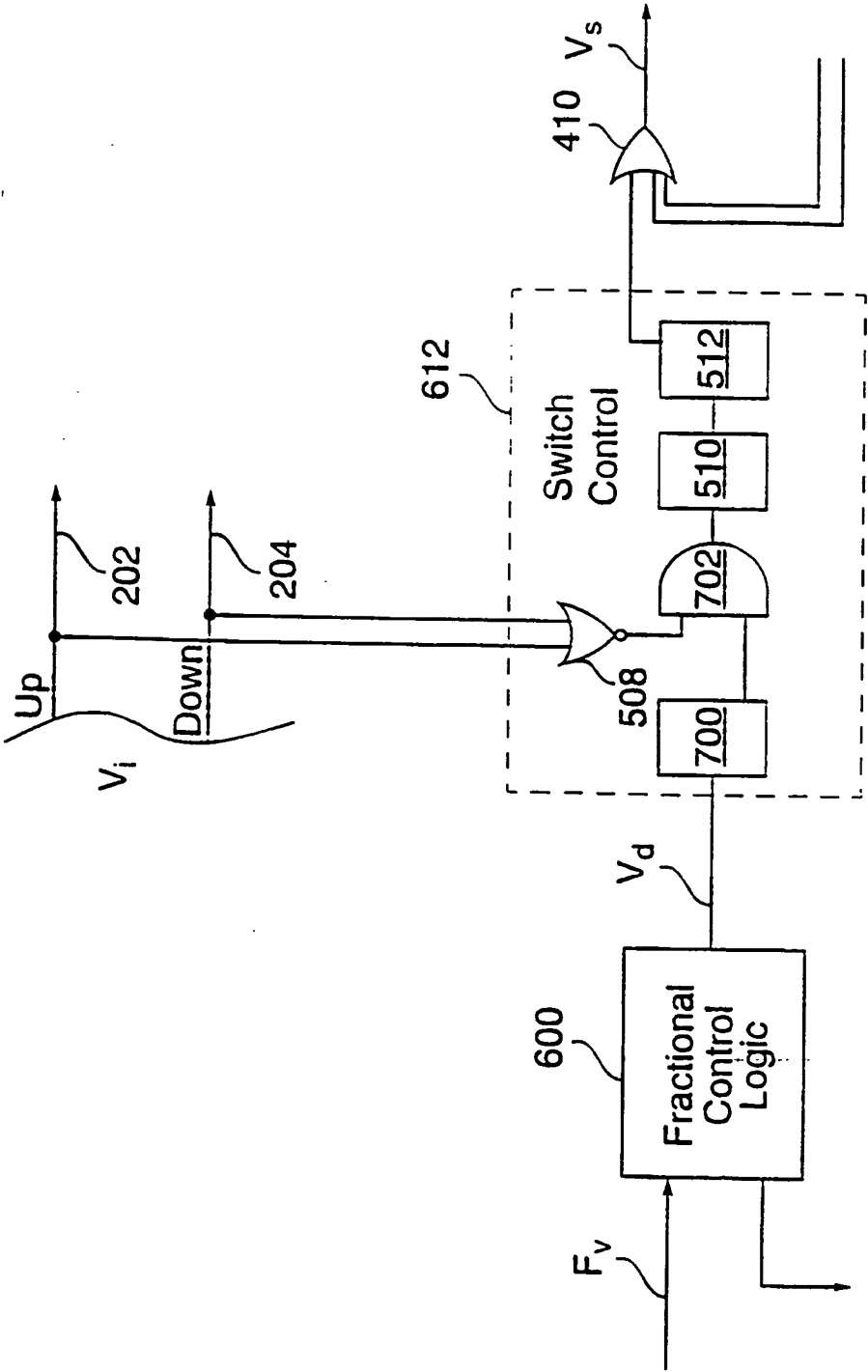


Fig. 7

Fig. 8A

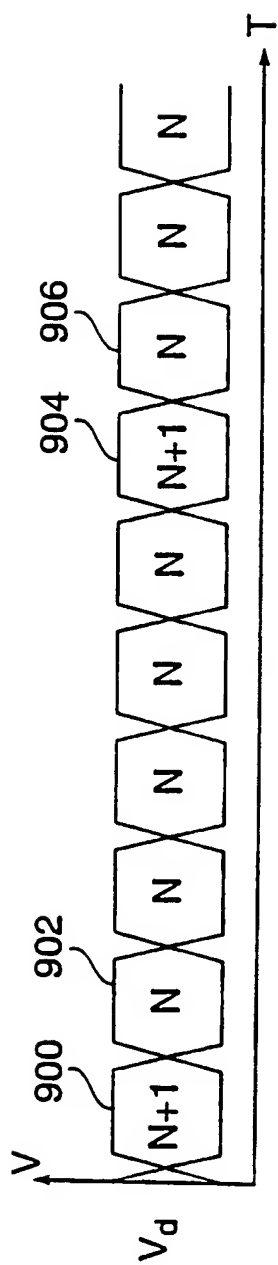


Fig. 88

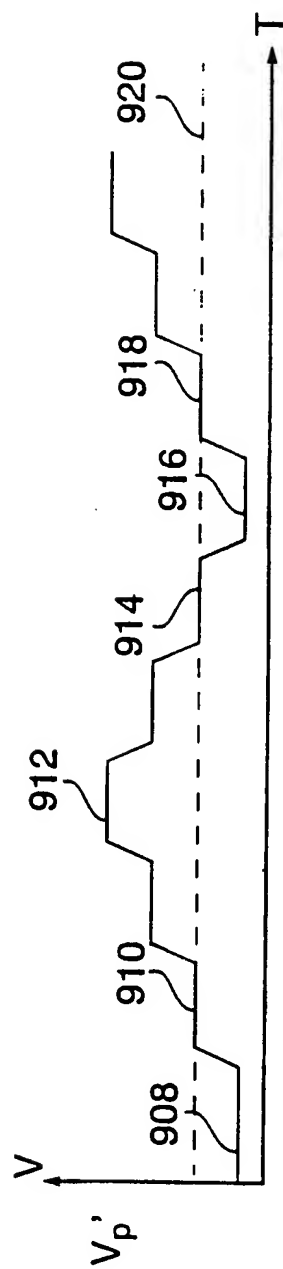


Fig. 8C

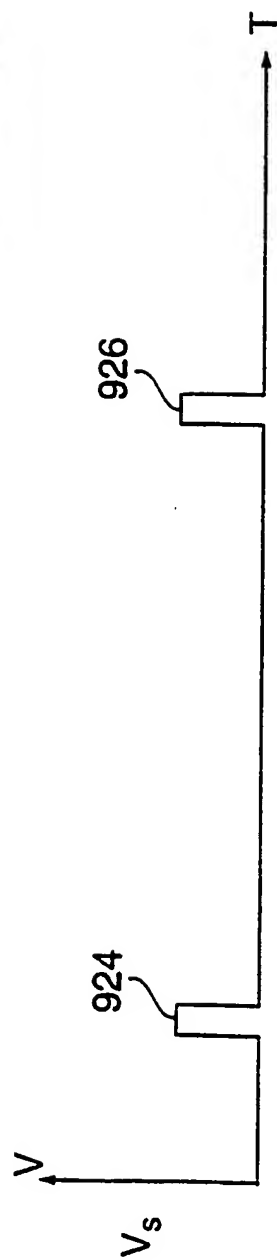
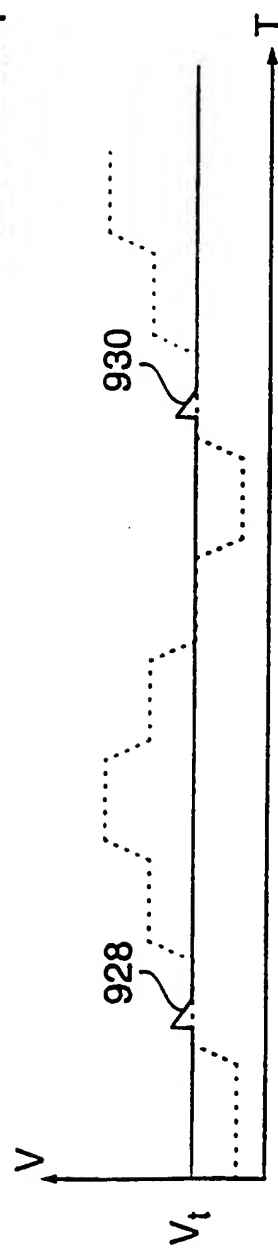


Fig. 8D



INTERNATIONAL SEARCH REPORT

International Application No

PCT/US 97/20612

A. CLASSIFICATION OF SUBJECT MATTER
IPC 6 H03L7/093

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC 6 H03L

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	US 5 008 629 A (M. OHBA ET. AL.) 16 April 1991	1-3, 5-8, 10-12, 15-17, 19-21, 24-26, 28-36, 39-41
Y	see column 3, line 39 - column 4, line 30; figure 1	
Y	US 4 929 917 A (F. YOKOGAWA ET. AL.) 29 May 1990 see column 8, line 20 - column 9, line 60; figure 10	4, 9, 13, 18, 22, 27, 37, 42 4, 9, 13, 18, 22, 27, 37, 42

☒ Further documents are listed in the continuation of box C.

☒ Patent family members are listed in annex.

* Special categories of cited documents :

"A" document defining the general state of the art which is not considered to be of particular relevance

"E" earlier document but published on or after the international filing date

"L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)

"O" document referring to an oral disclosure, use, exhibition or other means

"P" document published prior to the international filing date but later than the priority date claimed

"T" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention

"X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone

"Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art.

a document member of the same patent family

Date of the actual completion of the international search

4 March 1998

Date of mailing of the international search report

01/04/1998

Name and mailing address of the ISA

European Patent Office, P.B. 5818 Patentlaan 2
NL - 2280 HV Rijswijk
Tel. (+31-70) 340-2040, Tx. 31 651 epo nl,
Fax: (+31-70) 340-3016

Authorized officer

Butler, N

INTERNATIONAL SEARCH REPORT

International Application No

PCT/US 97/20612

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT

Category	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	EP 0 272 938 A (NTT CORP.) 29 June 1988 see column 11, line 3 - column 12, line 12; figure 14 ---	1
A	US 5 208 555 A (A. GRAHAM ET. AL.) 4 May 1993 see column 3, line 19 - column 5, line 2; figures 2,3 ---	1
A	US 4 433 308 A (H. HIRATA) 21 February 1984 see column 2, line 10 - column 3, line 29; figure 2 ---	1
A	US 5 548 249 A (M. SUMITA ET. AL.) 20 August 1996 see column 10, line 66 - column 13, line 26; figures 3,5 -----	1

INTERNATIONAL SEARCH REPORT

Information on patent family members

International Application No

PCT/US 97/20612

Patent document cited in search report	Publication date	Patent family member(s)	Publication date
US 5008629 A	16-04-91	JP 2004018 A JP 2033218 A JP 2663537 B	09-01-90 02-02-90 15-10-97
US 4929917 A	29-05-90	JP 2026128 A JP 2568110 B	29-01-90 25-12-96
EP 272938 A	29-06-88	JP 2053113 C JP 7093576 B JP 63290019 A JP 1959945 C JP 6093627 B JP 63158913 A CA 1290407 A DE 3750810 D DE 3750810 T US 5202906 A	10-05-96 09-10-95 28-11-88 10-08-95 16-11-94 01-07-88 08-10-91 12-01-95 22-06-95 13-04-93
US 5208555 A	04-05-93	NONE	
US 4433308 A	21-02-84	NONE	
US 5548249 A	20-08-96	JP 8046511 A	16-02-96